FAIRCHILD
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July 1996

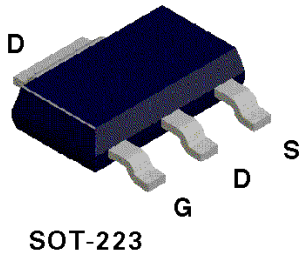
NDT455N
N-Channel Enhancement Mode Field Effect Transistor

General Description

These N-Channel logic level enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulses in the avalanche and commutation modes. These devices are particularly suited for low voltage applications such as DC motor control and DC/DC conversion where fast switching, low in-line power loss, and resistance to transients are needed.

Features

- 11.5 A, 30 V. $R_{DS(ON)}$ = 0.015 Ω @ V_{GS} = 10 V
  $R_{DS(ON)}$ = 0.02 Ω @ V_{GS} = 4.5 V.
- High density cell design for extremely low $R_{DS(ON)}$.
- High power and current handling capability in a widely used surface mount package.



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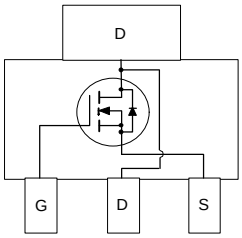

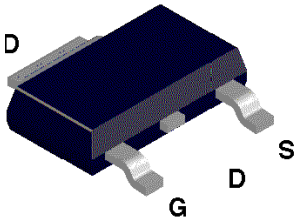

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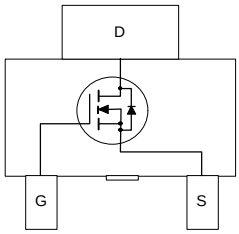
(J23Z)



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		NDT455N	Units
V_{DSS}	Drain-Source Voltage		30	V
V_{GSS}	Gate-Source Voltage		20	V
I_D	Drain Current - Continuous	(Note 1a)	± 11.5	A
	- Pulsed		± 40	
P_D	Maximum Power Dissipation	(Note 1a)	3	W
		(Note 1b)	1.3	
		(Note 1c)	1.1	
T_J,T_{STG}	Operating and Storage Temperature Range		-65 to 150	°C
THERMAL CHARACTERISTICS				
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	42	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	12	°C/W

Electrical Characteristics (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Typ	Max	Units
OFF CHARACTERISTICS							
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 µA		30			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 24 V, V_{GS} = 0 V				1	µA
			T_J = 55°C			10	µA
I_{GSSF}	Gate - Body Leakage, Forward	V_{GS} = 20 V, V_{DS} = 0 V				100	nA
I_{GSSR}	Gate - Body Leakage, Reverse	V_{GS} = -20 V, V_{DS} = 0 V				-100	nA
ON CHARACTERISTICS (Note 2)							
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 µA		1	1.5	3	V
			T_J = 125°C	0.7	0.9	2.2	
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS} = 10 V, I_D = 11.5 A			0.013	0.015	Ω
			T_J = 125°C		0.019	0.03	
		V_{GS} = 4.5 V, I_D = 10 A			0.018	0.02	
$I_{D(on)}$	On-State Drain Current	V_{GS} = 10 V , V_{DS} = 5 V		30			A
		V_{GS} = 4.5 V, V_{DS} = 5 V		15			
g_{FS}	Forward Transconductance	V_{GS} = 10 V, I_D = 11.5 A			26		S
DYNAMIC CHARACTERISTICS							
C_{iss}	Input Capacitance	V_{DS} = 15, V_{GS} = 0 V, f = 1.0 MHz			1220		pF
C_{oss}	Output Capacitance				715		pF
C_{rss}	Reverse Transfer Capacitance				280		pF
SWITCHING CHARACTERISTICS (Note 2)							
$t_{D(on)}$	Turn - On Delay Time	V_{DD} = 15 V, I_D = 1 A, V_{GEN} = 10 V, R_{GEN} = 6 Ω			11	20	ns
t_r	Turn - On Rise Time				16	30	ns
$t_{D(off)}$	Turn - Off Delay Time				48	80	ns
t_f	Turn - Off Fall Time				40	70	ns
Q_g	Total Gate Charge	V_{DS} = 10 V, I_D = 11.5 A, V_{GS} = 10 V			43	61	nC
Q_{gs}	Gate-Source Charge				4		nC
Q_{gd}	Gate-Drain Charge				11		nC

Electrical Characteristics (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
I_S	Maximum Continuous Drain-Source Diode Forward Current				2.5	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 2.5 A (Note 2)		0.845	1.2	V
t_{rr}	Reverse Recovery Time	V_{GS} = 0 V, I_F = 2.5 A dI_F/dt = 100 A/µs			140	ns

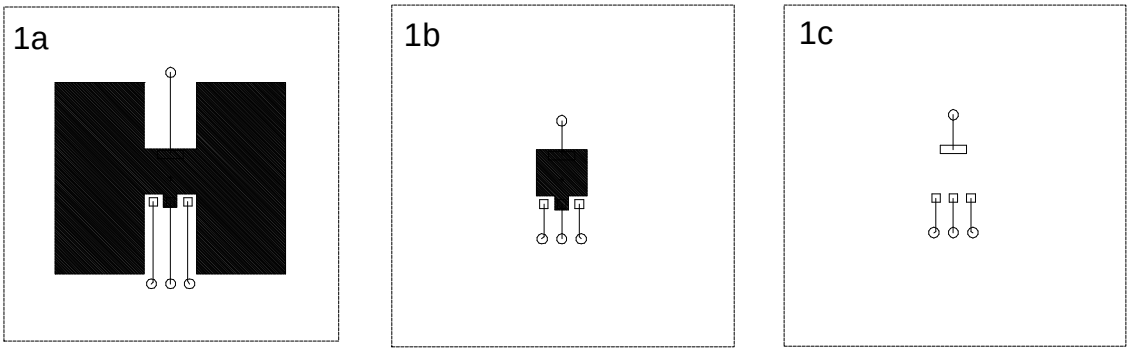
Notes:

1. $P_D(t) = \frac{T_J - T_A}{R_{\theta JA}(t)} = \frac{T_J - T_A}{R_{\theta JC} + R_{\theta CA}(t)} = I_D^2(t) \times R_{DS(ON)@T_J}$ $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is defined by users. For general reference: Applications on 4.5"x5" FR-4 PCB under still air environment, typical $R_{\theta JA}$ is found to be:

   a. 42°C/W with 1 in^2 of 2 oz copper mounting pad.

   b. 95°C/W with 0.066 in^2 of 2 oz copper mounting pad.

   c. 110°C/W with 0.0123 in^2 of 2 oz copper mounting pad.



Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2.0%.

Typical Electrical Characteristics

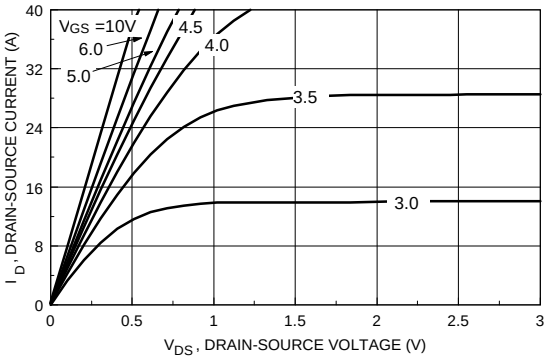


Figure 1. On-Region Characteristics.

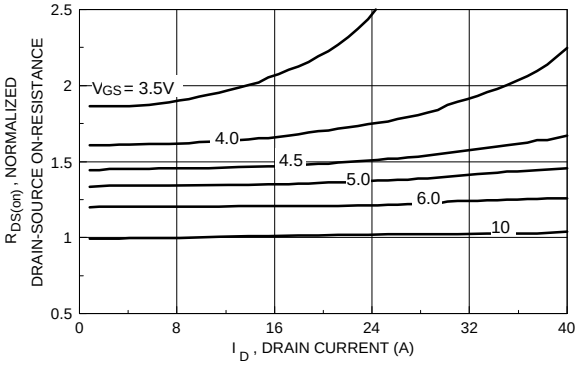


Figure 2. On-Resistance Variation with Gate Voltage and Drain Current.

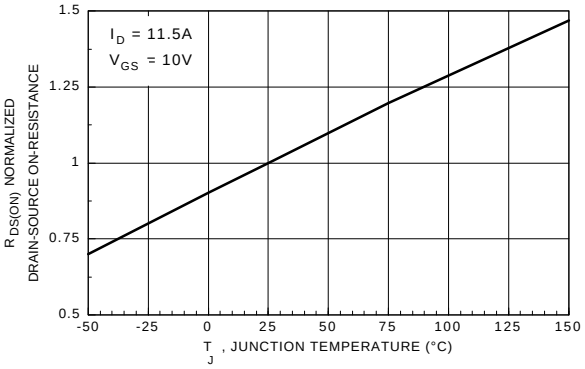


Figure 3. On-Resistance Variation with Temperature.

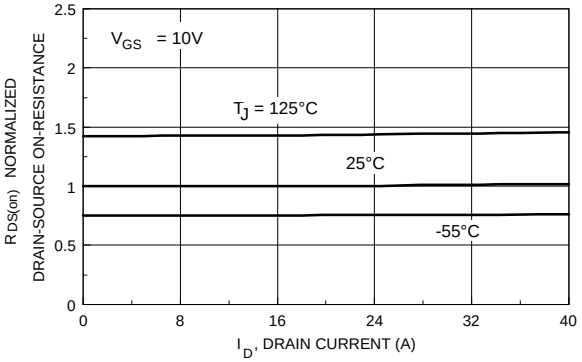


Figure 4. On-Resistance Variation with Drain Current and Temperature.

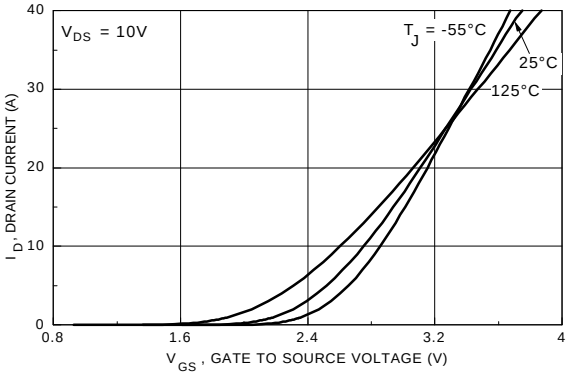


Figure 5. Transfer Characteristics.

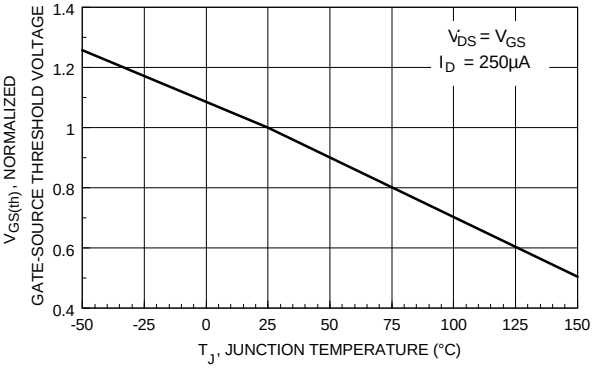


Figure 6. Gate Threshold Variation with Temperature.

Typical Electrical Characteristics

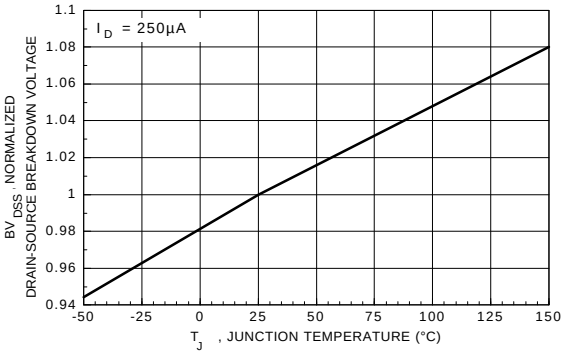


Figure 7. Breakdown Voltage Variation with Temperature.

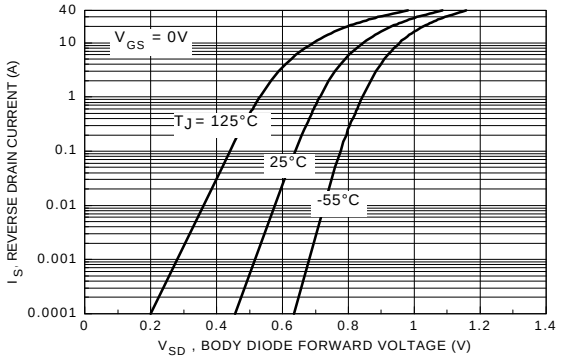


Figure 8. Body Diode Forward Voltage Variation with Current and Temperature.

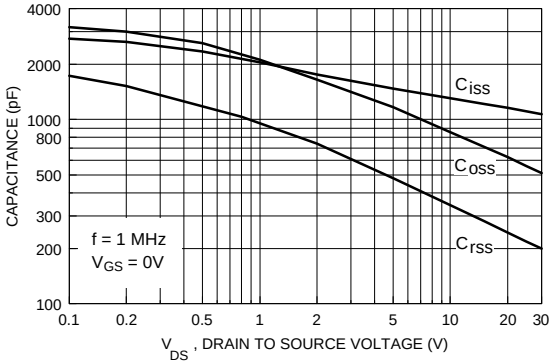


Figure 9. Capacitance Characteristics.

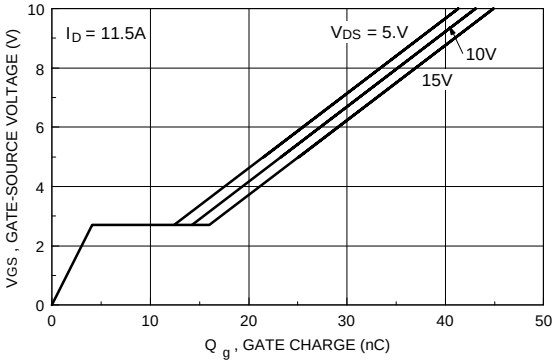


Figure 10. Gate Charge Characteristics.

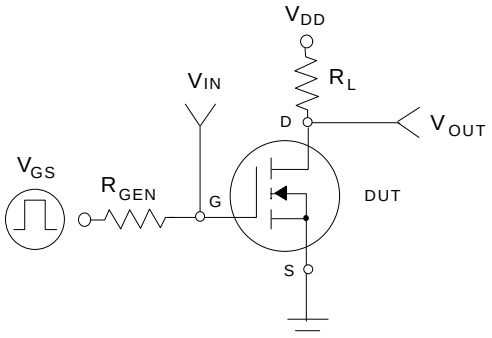


Figure 11. Switching Test Circuit.

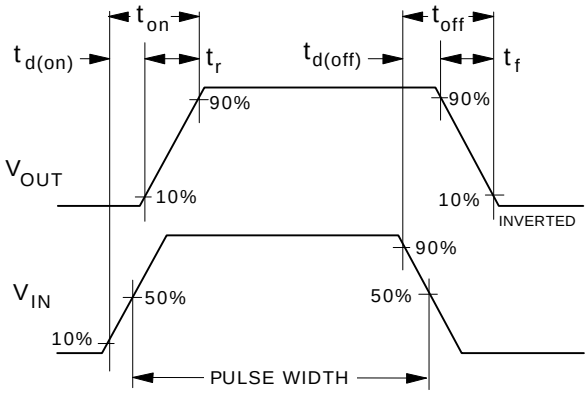


Figure 12. Switching Waveforms.

Typical Thermal Characteristics

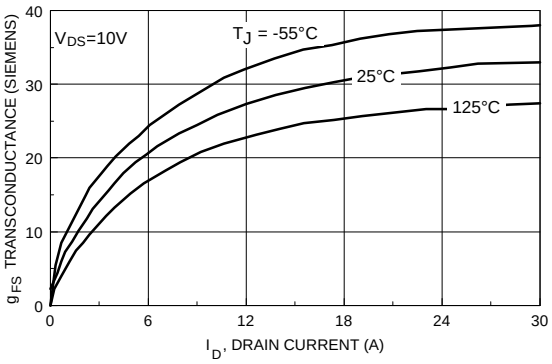


Figure 13. Transconductance Variation with Drain Current and Temperature.

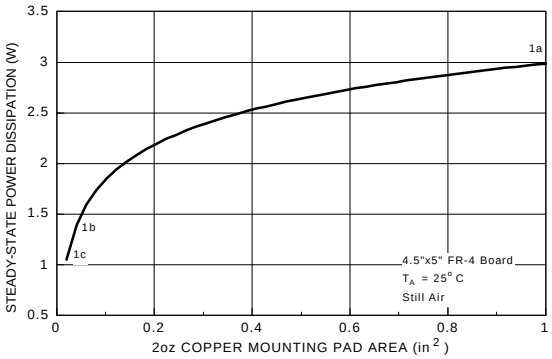


Figure 14. SOT-223 Maximum Steady- State Power Dissipation versus Copper Mounting Pad Area.

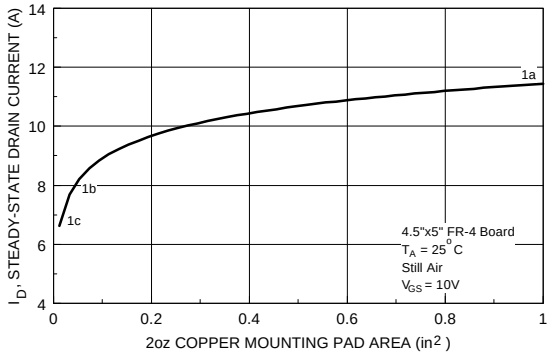


Figure 15. Maximum Steady-State DrainCurrent versus Copper Mounting Pad Area.

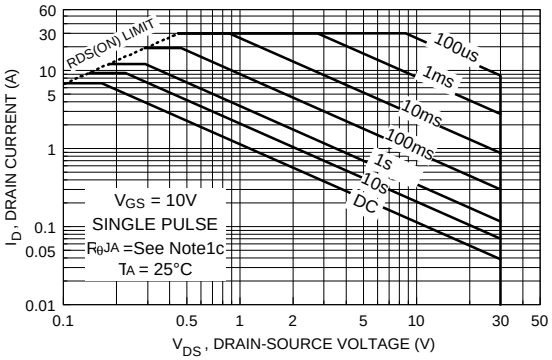


Figure 16. Maximum Safe Operating Area.

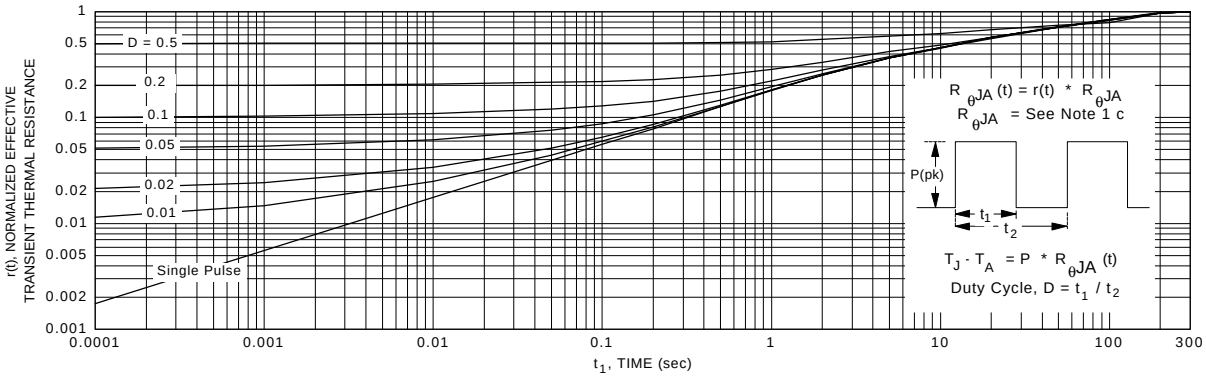


Figure 17. Typical Transient Thermal Impedance Curve.

Remark: Thermal characterization performed under the conditions of Note 1c. Should better thermal design employs, $R_{\theta JA}$ will be lower and reach thermal equivalent sooner.

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